

ON Semiconductor®

FDMA3027PZ

Dual P-Channel PowerTrench® MOSFET

-30 V, -3.3 A, 87 mΩ

Features

- Max $r_{DS(on)}$ = 87 m Ω at V_{GS} = -10 V, I_D = -3.3 A
- Max $r_{DS(on)} = 152 \text{ m}\Omega$ at $V_{GS} = -4.5 \text{ V}$, $I_D = -2.3 \text{ A}$
- HBM ESD protection level > 2 KV typical (Note 3)
- Low profile 0.8 mm maximum in the new package MicroFET 2x2 mm
- RoHS Compliant

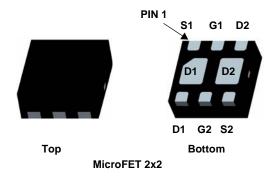


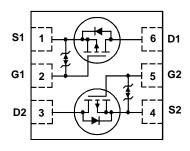
General Description

This device is designed specifically as a single package solution for dual switching requirements such as gate driver for larger Mosfets. It features two independent P-Channel MOSFETs with low on-state resistance for minimum conduction losses. The MicroFET 2x2 package offers exceptional thermal performance for its physical size and is well suited to linear mode applications. G-S zener has been added to enhance ESD voltage level.

Applications

- Load Switch
- Discrete Gate Driver





MOSFET Maximum Ratings T_A = 25 °C unless otherwise noted

Symbol	Parameter		Ratings	Units
V _{DS}	Drain to Source Voltage		-30	V
V_{GS}	Gate to Source Voltage		±25	V
	Drain Current -Continuous	(Note 1a)	-3.3	^
'D	-Pulsed		-15	A
P _D	Power Dissipation	(Note 1a)	1.4	w
	Power Dissipation	(Note 1b)	0.7	VV
T _J , T _{STG}	Operating and Storage Junction Temperature Range		-55 to +150	°C

Thermal Characteristics

R_{\thetaJA}	Thermal Resistance for Single Operation, Junction to Ambient	(Note 1a)	86	
	Thermal Resistance for Single Operation, Junction to Ambient	(Note 1b)	173	
	Thermal Resistance for Dual Operation, Junction to Ambient	(Note 1c)	69	°C/W
	Thermal Resistance for Dual Operation, Junction to Ambient	(Note 1d)	151	*C/VV
	Thermal Resistance for Single Operation, Junction to Ambient	(Note 1e)	160	
	Thermal Resistance for Dual Operation, Junction to Ambient	(Note 1f)	133	

Package Marking and Ordering Information

Device Marking	Device	Package	Reel Size	Tape Width	Quantity
327	FDMA3027PZ	MicroFET 2X2	7 "	8 mm	3000 units

Electrical Characteristics $T_J = 25$ °C unless otherwise noted

Symbol	Parameter Test Conditions		Min	Тур	Max	Units
Off Chara	acteristics					
BV _{DSS}	Drain to Source Breakdown Voltage	$I_D = -250 \mu A, V_{GS} = 0 V$	-30			V
$\frac{\Delta BV_{DSS}}{\Delta T_{J}}$	Breakdown Voltage Temperature Coefficient	I_D = -250 μ A, referenced to 25 °C		-22		mV/°C
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} = -24 V, V _{GS} = 0 V			-1	μА
I _{GSS}	Gate to Source Leakage Current	$V_{GS} = \pm 25 \text{ V}, V_{DS} = 0 \text{ V}$			±10	μА

On Characteristics

V _{GS(th)}	Gate to Source Threshold Voltage	$V_{GS} = V_{DS}$, $I_D = -250 \mu A$	-1	-1.9	-3	V
$\frac{\Delta V_{GS(th)}}{\Delta T_J}$	Gate to Source Threshold Voltage Temperature Coefficient	I_D = -250 μ A, referenced to 25 °C		5		mV/°C
		$V_{GS} = -10 \text{ V}, I_D = -3.3 \text{ A}$		69	87	
r _{DS(on)}	Static Drain to Source On Resistance	$V_{GS} = -4.5 \text{ V}, I_D = -2.3 \text{ A}$		108	152	mΩ
		$V_{GS} = -10 \text{ V}, I_D = -3.3 \text{ A}, T_J = 125 \text{ °C}$		97	122	
9 _{FS}	Forward Transconductance	$V_{DS} = -5 \text{ V}, I_{D} = -3.3 \text{ A}$		6		S

Dynamic Characteristics

C _{iss}	Input Capacitance	V 45 V V 0 V	324	435	pF
Coss	Output Capacitance	V _{DS} = -15 V, V _{GS} = 0 V, f = 1 MHz	59	80	pF
C _{rss}	Reverse Transfer Capacitance	1 - 1 101112	53	80	pF
R_g	Gate Resistance		12		Ω

Switching Characteristics

t _{d(on)}	Turn-On Delay Time				5.2	11	ns
t _r	Rise Time	V _{DD} = -15 V, I _D = -3	V_{DD} = -15 V, I_{D} = -3.3 A, V_{GS} = -10 V, R_{GEN} = 6 Ω		3	10	ns
t _{d(off)}	Turn-Off Delay Time	V _{GS} = -10 V, R _{GEN}			17	31	ns
t _f	Fall Time				11	25	ns
0	Total Gate Charge	$V_{GS} = 0 V \text{ to -10 } V$			7.2	10	nC
$Q_{g(TOT)}$	Total Gate Charge	$V_{GS} = 0 V \text{ to -5 } V$	V _{DD} = -15 V,		4.1	6	nC
Q_{gs}	Gate to Source Charge		$I_D = -3.3 \text{ A}$		1.0		nC
Q_{gd}	Gate to Drain "Miller" Charge				1.9		nC

Drain-Source Diode Characteristics

V_{SD}	Source to Drain Diode Forward Voltage	$V_{GS} = 0 \text{ V}, I_{S} = -3.3 \text{ A}$	(Note 2)	-0.94	-1.3	V
t _{rr}	Reverse Recovery Time	I _F = -3.3 A, di/dt = 100 A/μs		20	32	ns
Q _{rr}	Reverse Recovery Charge			10	18	nC

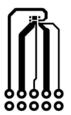
Electrical Characteristics T_J = 25 °C unless otherwise noted

Notes:

- 1. $R_{\theta JA}$ is determined with the device mounted on a 1 in² oz. copper pad on a 1.5 x 1.5 in. board of FR-4 material. $R_{\theta JC}$ is guaranteed by design while $R_{\theta JA}$ is determined by the user's board design.
 - (a) $R_{\theta,JA} = 86 \, ^{\circ}\text{C/W}$ when mounted on a 1 in² pad of 2 oz copper, 1.5 " x 1.5 " x 0.062 " thick PCB. For single operation.
 - (b) $R_{\theta JA}$ = 173 °C/W when mounted on a minimum pad of 2 oz copper. For single operation.
 - (c) $R_{\theta,JA} = 69$ °C/W when mounted on a 1 in² pad of 2 oz copper, 1.5 " x 1.5 " x 0.062 " thick PCB. For dual operation.
 - (d) $\rm R_{\theta JA}$ = 151 $^{o}C/W$ when mounted on a minimum pad of 2 oz copper. For dual operation.
 - (e) $R_{\theta,JA} = 160$ °C/W when mounted on a 30 mm² pad of 2 oz copper. For single operation.
 - (f) $R_{\theta,JA} = 133$ °C/W when mounted on a 30 mm² pad of 2 oz copper. For dual operation.



a. 86 °C/W when mounted on a 1 in² pad of 2 oz copper



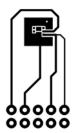
b. 173 °C/W when mounted on a minimum pad of 2 oz copper



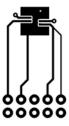
c. 69 °C/W when mounted on a 1 in² pad of 2 oz copper



d. 151 °C/W when mounted on a minimum pad of 2 oz copper



e. 160 °C/W when mounted on 30 mm² pad of 2 oz copper



f. 133 °C/W when mounted on 30 mm² pad of 2 oz copper

- 2. Pulse Test : Pulse Width < 300 us, Duty Cycle < 2.0%
- 3. The diode connected between gate and source serves only as protection against ESD. No gate overvoltage rating is implied.

Typical Characteristics T_J = 25 °C unless otherwise noted

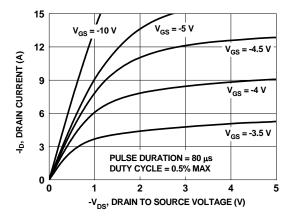


Figure 1. On-Region Characteristics

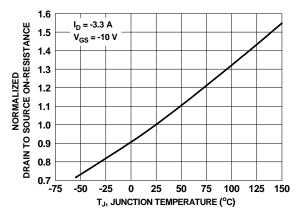


Figure 3. Normalized On-Resistance vs Junction Temperature

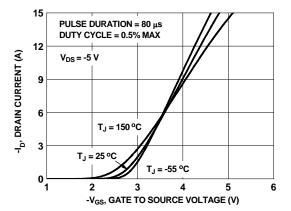


Figure 5. Transfer Characteristics

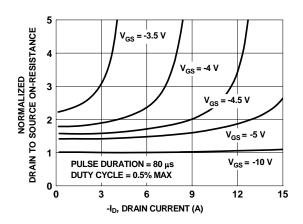


Figure 2. Normalized On-Resistance vs Drain Current and Gate Voltage

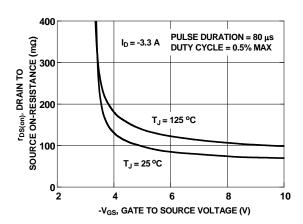


Figure 4. On-Resistance vs Gate to Source Voltage

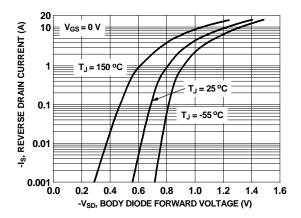


Figure 6. Source to Drain Diode Forward Voltage vs Source Current

Typical Characteristics $T_J = 25$ °C unless otherwise noted

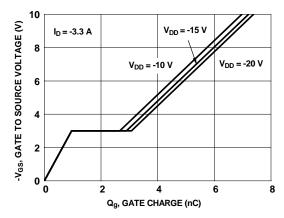


Figure 7. Gate Charge Characteristics

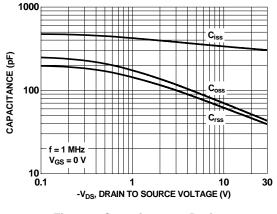


Figure 8. Capacitance vs Drain to Source Voltage

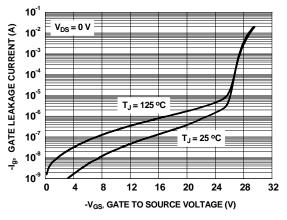


Figure 9. Gate Leakage Current vs Gate to Source Voltage

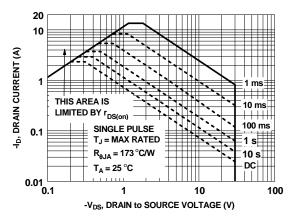


Figure 10. Forward Bias Safe Operating Area

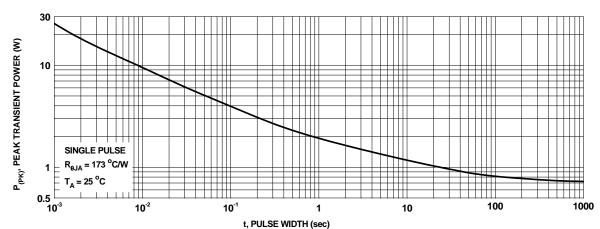


Figure 11. Single Pulse Maximum Power Dissipation



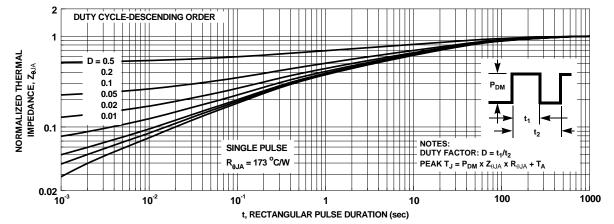
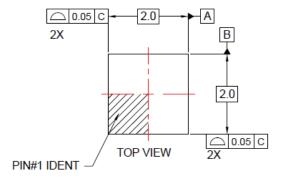
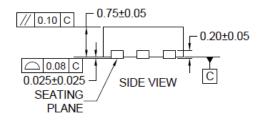
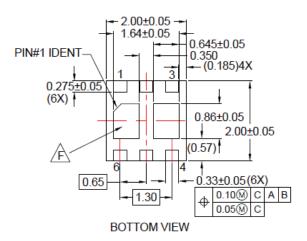


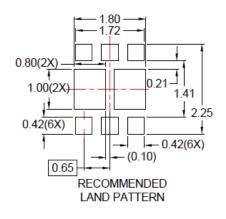
Figure 12. Junction-to-Ambient Transient Thermal Response Curve

Dimensional Outline and Pad Layout









NOTES:

- A. CONFORM TO JADEC REGISTRATIONS MO-229, VARIATION VCCC. EXCEPT WHERE NOTED.
- B. DIMENSIONS ARE IN MILLIMETERS.
- C. DIMENSIONS AND TOLERANCES PER ASME Y14.5M, 2009.
- D. LAND PATTERN RECOMMENDATION IS EXISTING INDUSTRY LAND PATTERN.
- E. DRAWING FILENAME: MKT-UMLP16Erev4
- F. NON-JEDEC DUAL DAP

Package drawings are provided as a service to customers considering ON Semiconductor components. Drawings may change in any manner without notice. Please note the revision and/or date on the drawing and contact a ON Semiconductor representative to verify or obtain the most recent revision. Package specifications do not expand the terms of ON Semiconductor's worldwide terms and conditions, specif-ically the warranty therein, which covers ON Semiconductor products.

ON Semiconductor and in are trademarks of Semiconductor Components Industries, LLC dba ON Semiconductor or its subsidiaries in the United States and/or other countries. ON Semiconductor owns the rights to a number of patents, trademarks, copyrights, trade secrets, and other intellectual property. A listing of ON Semiconductor's product/patent coverage may be accessed at www.onsemi.com/site/pdf/Patent-Marking.pdf. ON Semiconductor reserves the right to make changes without further notice to any products herein. ON Semiconductor makes no warranty, representation or guarantee regarding the suitability of its products for any particular purpose, nor does ON Semiconductor assume any liability arising out of the application or use of any product or circuit, and specifically disclaims any and all liability, including without limitation special, consequential or incidental damages. Buyer is responsible for its products and applications using ON Semiconductor products, including compliance with all laws, regulations and safety requirements or standards, regardless of any support or applications information provided by ON Semiconductor. "Typical" parameters which may be provided in ON Semiconductor data sheets and/or specifications can and do vary in different applications and actual performance may vary over time. All operating parameters, including "Typicals" must be validated for each customer application by customer's technical experts. ON Semiconductor does not convey any license under its patent rights nor the rights of others. ON Semiconductor products are not designed, intended, or authorized for use as a critical component in life support systems or any FDA Class 3 medical devices or medical devices with a same or similar classification in a foreign jurisdiction or any devices intended for implantation in the human body. Should Buyer purchase or use ON Semiconductor products for any such unintended or unauthorized application, Buyer shall indemnify and hol

PUBLICATION ORDERING INFORMATION

LITERATURE FULFILLMENT:

Literature Distribution Center for ON Semiconductor 19521 E. 32nd Pkwy, Aurora, Colorado 80011 USA Phone: 303-675-2175 or 800-344-3860 Toll Free USA/Canada Fax: 303-675-2176 or 800-344-3867 Toll Free USA/Canada Email: orderlit@onsemi.com N. American Technical Support: 800-282-9855 Toll Free USA/Canada Europe, Middle East and Africa Technical Support: Phone: 421 33 790 2910

Phone: 421 33 790 2910

Japan Customer Focus Center
Phone: 81–3–5817–1050

ON Semiconductor Website: www.onsemi.com

Order Literature: http://www.onsemi.com/orderlit

For additional information, please contact your local Sales Representative